

<b>Notice of References Cited</b>	Application/Control No. 09/457,952		Applicant(s)/Patent Under Reexamination SEBIRE ET AL.	
	Examiner David Q. Nguyen		Art Unit 2617	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,983,104	11-1999	Wickman et al.	455/441
*	B	US-5,787,348	07-1998	Willey et al.	455/441
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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